

## 3134-100M

### 100 Watts, 36 Volts, 100µs, 10% Radar 3100-3400 MHz

#### **GENERAL DESCRIPTION**

The 3134-100M is an internally matched, COMMON BASE bipolar transistor capable of providing 100 Watts of pulsed RF output power at 100µs pulse width, 10% duty factor across the 3100 to 3400 MHz band. This hermetically solder-sealed transistor is specifically designed for S-band radar applications. It utilizes gold metallization and emitter ballasting to provide high reliability and supreme ruggedness.

#### CASE OUTLINE 55KS-1 Common Base

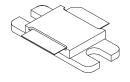
#### ABSOLUTE MAXIMUM RATINGS

#### **Maximum Voltage and Current**

 $\begin{array}{lll} \mbox{Collector to Base Voltage (BV_{ces})} & \mbox{65 V} \\ \mbox{Emitter to Base Voltage (BV_{ebo})} & \mbox{3.0 V} \\ \mbox{Collector Current (I_c)} & \mbox{17 A} \\ \end{array}$ 

#### **Maximum Temperatures**

Storage Temperature  $-65 \text{ to } +200 \text{ }^{\circ}\text{C}$ Operating Junction Temperature  $+200 \text{ }^{\circ}\text{C}$ 



#### **ELECTRICAL CHARACTERISTICS @ 25°C**

SYMBOL	CHARACTERISTICS	TEST CONDITIONS	MIN	TYP	MAX	UNITS
P <sub>out</sub>	Power Output	F=3100-3400 MHz	100		135	W
Gain	Power Gain	Vcc = 36V	8.0		9.3	
$\eta_c$	Collector Efficiency	Pulse Width = 100 us	40			%
Droop	Droop	Duty Cycle = 10%			0.5	dB
IRL	Input Return Loss	Pin = 16W			-7	dB
VSWR-S	Stability		1.5:1			
VSWR-T	Survivability		2.0:1			

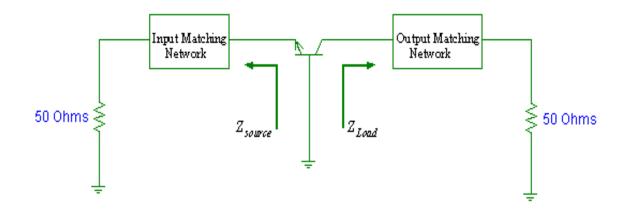
#### **FUNCTIONAL CHARACTERISTICS @ 25°C**

SYMBOL	CHARACTERISTICS	TEST CONDITIONS	MIN	TYP	MAX	UNITS
$\mathrm{BV}_{\mathrm{ebo}}$	Emitter to Base Breakdown	Ie = 30  mA	3.0			V
$BV_{ces}$	Collector to Emitter Breakdown	Ic = 60  mA	65			V
Ices	Collector to Emitter Leakage	Vce = 36 V			5	mA
θјс	Thermal Resistance				0.35	°C/W
Tstg	Storage Temperature		-65		200	°C



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### **Input and Output Impedance**

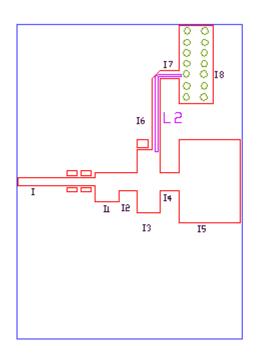


Impedance Data						
Freq (GHz)	Zsource	Zload				
3.1	12.15 – j3.61	4.16 - j5.98				
3.2	11.78 - j5.17	4.17- j5.69				
3.3	10.84 - j6.46	4.21 - j5.42				
3.4	9.58 - j7.29	4.26 - j5.16				



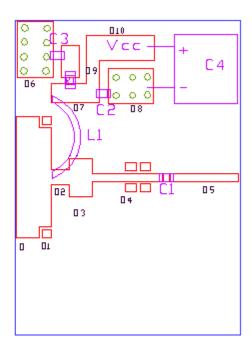
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#### **Broadband Test Circuit**



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Input Matching Network			(	Output Matching Network			Circuit Components & Value		
Item	W(mil)	L(mil)		Item	W(mil)	L(mil)	ltem	Value	
	35	342		0	542	103	C1	9.1pF (A size)	
l1	128	106		01	442	50	C2	100pF (A size)	
12	80	82		02	65	83	C3	10,000pF (B size)	
13	280	100		03	170	102	C4	1,000uF (Electrolytic)	
14	80	85		04	35	318	R1	8.2 Ohms (size 8050)	
15	370	275		05	35	310	L1	20 AWG, L=550mils	
16	35	320		90	252	164	L2	20 AWG, L=550mils	
17	35	85		07	86	216	Board	Duroid 6006 @25 Mils Thickness, Er=6.15	
18	348	154		08	152	200			
				09	215	56			

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